Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSIII)

# 2SK2733

# Chopper Regulator, DC-DC Converter and Motor Drive Applications

• Low drain–source ON resistance : RDS (ON) = 8.0  $\Omega$  (typ.)

• High forward transfer admittance  $: |Y_{fs}| = 0.9 \text{ S (typ.)}$ 

• Low leakage current :  $IDSS = 100 \mu A \text{ (max) (VDS} = 720 \text{ V)}$ 

• Enhancement-mode :  $V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$ 

### **Maximum Ratings (Ta = 25°C)**

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	900	V	
Drain-gate voltage (R <sub>GS</sub> = 20 kΩ)		$V_{DGR}$	900	V	
Gate-source voltage		V <sub>GSS</sub>	±30	V	
Drain current	DC (Note 1)	I <sub>D</sub>	1	Α	
	Pulse (Note 1)	$I_{DP}$	3	A	
Drain power dissipation	n (Tc = 25°C)	P <sub>D</sub>	60	W	
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	324	mJ	
Avalanche current		I <sub>AR</sub>	1	Α	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	6.0	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55~150	°C	

# 10.3MAX. 93.6±0.2 1.6MAX. 93.

Weight: 2.0 g (typ.)

### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	2.08	°C / W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	83.3	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25°C (initial), L = 594 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AR}$  = 1 A

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device.

Please handle with caution.

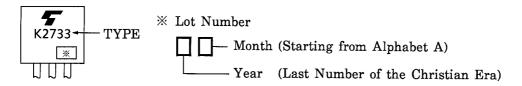
## **Electrical Characteristics (Ta = 25°C)**

Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±30 V, V <sub>DS</sub> = 0 V	_	_	±10	μA
Gate-source bre	eakdown voltage	V <sub>(BR)</sub> GSS	$I_G = \pm 10 \ \mu A, \ V_{DS} = 0 \ V$	±30	_	_	V
Drain cut-off cur	rent	I <sub>DSS</sub>	V <sub>DS</sub> = 720 V, V <sub>GS</sub> = 0 V	_	_	100	μΑ
Drain-source br	eakdown voltage	V <sub>(BR)DSS</sub>	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	900	_	_	V
Gate threshold v	roltage	$V_{th}$	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.0	_	4.0	V
Drain-source Ol	N resistance	R <sub>DS (ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.5 A	_	8.0	9.0	Ω
Forward transfer	admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 0.5 A	0.2	0.9	_	S
Input capacitanc	е	C <sub>iss</sub>			370	_	pF
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	5	_	
Output capacitance		C <sub>oss</sub>			40	_	1
Switching time	Rise time	t <sub>r</sub>	$V_{GS} \stackrel{10V}{_{0V}} \stackrel{I_{D}=1A}{_{CI}} \circ V_{out}$ $R_{L}=200\Omega$ $V_{DD}=200V$	_	20	_	- ns
	Turn-on time	t <sub>on</sub>		_	70	_	
	Fall time	t <sub>f</sub>		_	30	_	
	Turn-off time	t <sub>off</sub>	Duty $\leq 1\%$ , $t_w = 10 \mu s$	_	95	_	
Total gate charge (gate-source plus gate-drain)		Qg	V <sub>DD</sub> ≈ 400 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1 A		15	_	nC
Gate-source charge		Q <sub>gs</sub>			6	_	
Gate-drain ("miller") Charge		$Q_{gd}$			9	_	

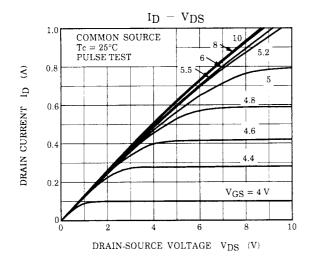
# Source-Drain Ratings and Characteristics (Ta = 25°C)

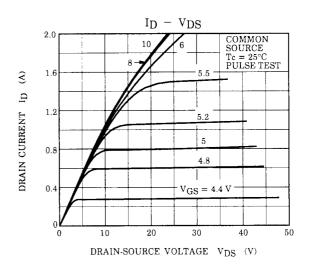
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_		_	1	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	-		_	3	Α
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 1 A, V <sub>GS</sub> = 0 V	_	_	-1.9	V
Reverse recovery time	t <sub>rr</sub>	I <sub>DR</sub> = 1 A, V <sub>GS</sub> = 0 V	_	750	_	ns
Reverse recovery charge	Q <sub>rr</sub>	dl <sub>DR</sub> / dt = 100 A / μs	-	3	_	μC

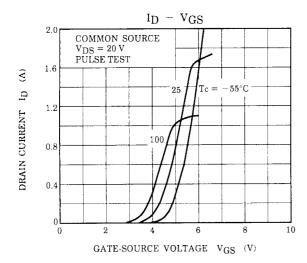
# Marking

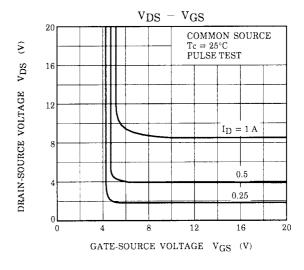


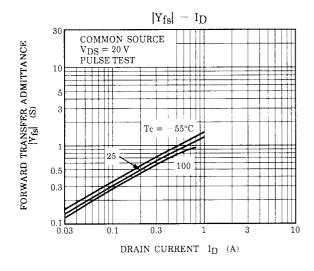
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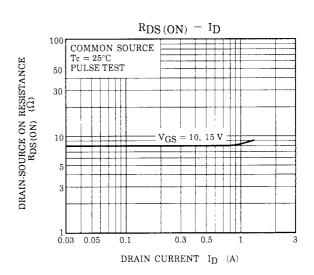




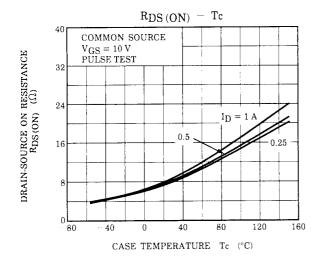


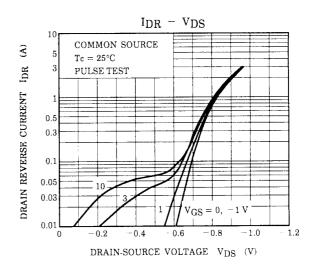


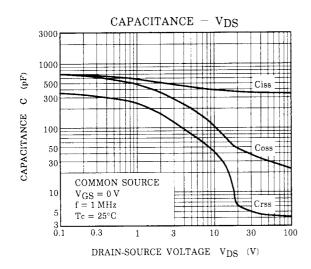


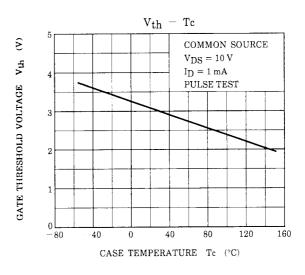


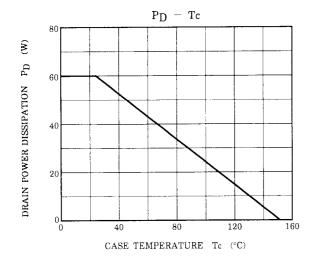
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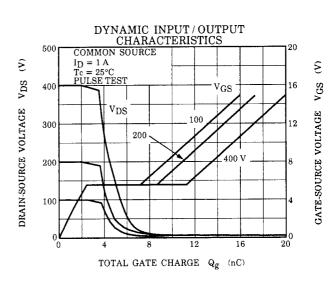




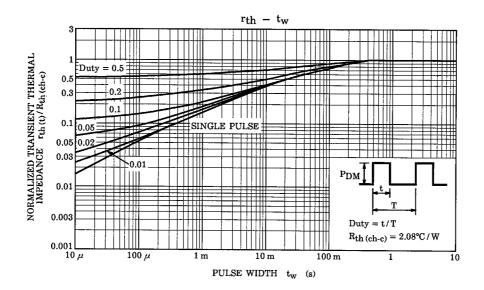


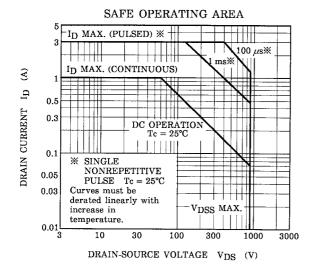


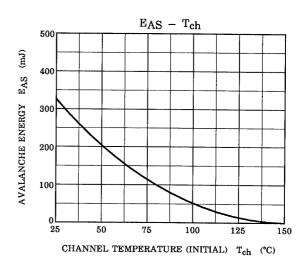


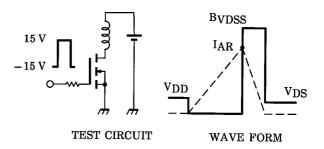


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$$\begin{aligned} R_G &= 25~\Omega \\ V_{DD} &= 90~V,~L = 594~mH \end{aligned} \qquad EAS &= \frac{1}{2} \cdot L \cdot I^2 \cdot \left( \frac{BVDSS}{BVDSS - VDD} \right) \end{aligned}$$

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